

DM77/87S184 (2048 x 4) 8192-Bit TTL PROM

General Description

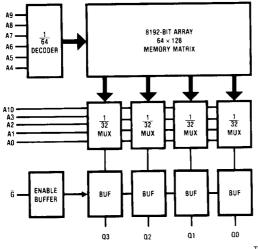
This Schottky memory is organized in the popular 2048 words by 4 bits configuration. A memory enable input is provided to control the output states. When the device is enabled, the outputs represent the contents of the selected word. When disabled, the 4 outputs go to the "OFF" or high impedance state.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions.

Features

- Advanced titanium-tungsten (Ti-W) fuses
- Schottky-clamped for high speed Address access—55 ns max Enable access—25 ns max Enable recovery—25 ns max
- PNP inputs for reduced input loading
- All DC and AC parameters guaranteed over temperature
- Low voltage TRI-SAFE™ programming
- Open-collector outputs

Block Diagram



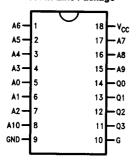
Pin Names

A0-A10	Addresses					
G	Output Enable					
GND	Ground					
Q0-Q3	Outputs					
V _{CC}	Power Supply					

TL/D/9717-1

Connection Diagrams

Dual-In-Line Package

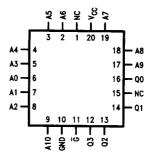


TL/D/9717-2

Top View

Order Number DM77/87S184J, 184AJ or DM87S184N, 184AN See NS Package Number J18A or N18A

Plastic Leaded Chip Carrier (PLCC)



TL/D/9717-3 **Top View**

Order Number DM87S184V, 184AV See NS Package Number V20A

Ordering Information

Commercial Temp Range (0°C to +70°C)

Parameter/Order Number	Max Acces Time (ns)				
DM87S184AN	45				
DM87S184N	55				
DM87S184AJ	45				
DM87S184J	55				
DM87S184AV	45				
DM87S184V	55				

Military Temp Range (-55°C to +125°C)

Parameter/Order Number	Max Acces Time (ns)
DM77S184J	70
DM77S184AJ	60

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications. Supply Voltage (Note 2) -0.5V to +7.0VInput Voltage (Note 2) -1.2V to +5.5V-0.5V to +5.5VOutput Voltage (Note 2) -65°C to +150°C

Storage Temperature ESD to be determined.

Lead Temp. (Soldering, 10 seconds)

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at these values.

Note 2: These limits do not apply during programming. For the programming ratings, refer to the programming instructions.

Operating Conditions Min Max Units Supply Voltage (V _{CC}) V Military 4.50 5.50 V Commercial 4.75 5.25 V Ambient Temperature (T _A) Military -55 +125 °C Commercial 0 +70 °C Logical (**O') Input Voltage 0 0.9 V					
	Min	Max	Units		
Supply Voltage (V _{CC})					
Military	4.50	5.50	V		
Commercial	4.75	5.25	٧		
Ambient Temperature (TA)					
Military	-55	+ 125	°C		
Commercial	0	+70	°C		
Logical "0" Input Voltage	0	0.8	V		
Logical "1" Input Voltage	2.0	5.5	V		

DC Electrical Characteristics (Note 1)

Symbol Parameter	Parameter	Conditions	DM77S184			DM87S184			Units
	Conditions	Min	Тур	Max	Min	Тур	Max	Units	
կլ	Input Load Current	V _{CC} = Max, V _{IN} = 0.45V		-80	-250		-80	-250	μΑ
Iн	Input Leakage Current	V _{CC} = Max, V _{IN} = 2.7V			26			25	μΑ
		V _{CC} = Max, V _{IN} = 5.5V			1.0			1.0	mΑ
V _{OL}	Low Level Output Voltage	V _{CC} = Min, I _{OL} = 16 mA		0.35	0.50		0.35	0.45	>
V _{IL}	Low Level Input Voltage				0.80			0.80	٧
V _{IH}	High Level Input Voltage		2.0			2.0			V
loz	Output Leakage Current (Open-Collector Only)	V _{CC} = Max, V _{CEX} = 2.4V			50			50	μΑ
		V _{CC} = Max, V _{CEX} = 5.5V			100			100	μΑ
V _C	Input Clamp Voltage	V _{CC} = Min, I _{IN} = -18 mA		-0.8	-1.2		-0.8	-1.2	٧
CI	Input Capacitance	V _{CC} = 5.0V, V _{IN} = 2.0V T _A = 25°C, 1 MHz		4.0			4.0		pF
СО	Output Capacitance	$V_{CC} = 5.0V$, $V_{O} = 2.0V$ $T_{A} = 25$ °C, 1 MHz, Outputs Off		6.0			6.0		рF
Icc	Power Supply Current	V _{CC} = Max, Input Grounded All Outputs Open		100	140		100	140	mA

300°C

Note 1: These limits apply over the entire operating range unless otherwise noted. All typical values are for V_{CC} = 5.0V and T_A = 25°C.

AC Electrical Characteristics with Standard Load and Operating Conditions

COMMERCIAL TEMP RANGE (0°C to +70°C)

Symbol JEDEC Symbol		Parameter	DM87S184				Units		
	- uramotor	Min	Тур	Max	Min	Тур	Max	Office	
TAA	TAVQV	Address Access Time		40	55		30	45	ns
TEA	TEVQV	Enable Access Time		15	25		15	25	ns
TER	TEXQX	Enable Recovery Time		15	25		15	25	ns

MILITARY TEMP RANGE (-55°C to +125°C)

Symbol JEDEC Symbol		Parameter	DM77S184				Units		
	l	Min	Тур	Max	Min	Тур	Max	Oilles	
TAA	TAVQV	Address Access Time		40	70		30	60	ns
TEA	TEVQV	Enable Access Time		15	30		15	30	ns
TER	TEXQX	Enable Recovery Time		15	30		15	30	ns

Functional Description

TESTABILITY

The Schottky PROM die includes extra rows and columns of fusable links for testing the programmability of each chip. These test fuses are placed at the worst-case chip locations to provide the highest possible confidence in the programming tests in the final product. A ROM pattern is also permanently fixed in the additional circuitry and coded to provide a parity check of input address levels. These and other test circuits are used to test for correct operation of the row and column-select circuits and functionality of input and enable gates. All test circuits are available at both wafer and assembled device levels to allow 100% functional and parametric testing at every stage of the test flow.

RELIABILITY

As with all National products, the Ti-W PROMs are subjected to an on-going reliability evaluation by the Reliability Assurance Department. These evaluations employ accelerated life tests, including dynamic high-temperature operating life, temperature-humidity life, temperature cycling, and thermal shock. To date, nearly 7.4 million Schottky Ti-W PROM device hours have been logged, with samples in Epoxy B molded DIP (N-package), PLCC (V-package) and CERDIP (J-package). Device performance in all package configurations is excellent.

TITANIUM-TUNGSTEN FUSES

National's Programmable Read-Only Memories (PROMs) feature titanium-tungsten (Ti-W) fuse links designed to program efficiently with only 10.5V applied. The high performance and reliability of these PROMs are the result of fabrication by a Schottky bipolar process, of which the titanium-tungsten metallization is an integral part, and the use of an on-chip programming circuit.

A major advantage of the titanium-tungsten fuse technology is the low programming voltage of the fuse links. At 10.5V, this virtually eliminates the need for guard-ring devices and wide spacings required for other fuse technologies. Care is taken, however, to minimize voltage drops across the die and to reduce parasitics. The device is designed to ensure that worst-case fuse operating current is low enough for reliable long-term operation. The Darlington programming circuit is liberally designed to insure adequate power density for lowing the fuse links. The complete circuit design is optimized to provide high performance over the entire operating ranges of V_{CC} and temperature.